

## Certificate of non-use of The Controlled Substances

Company name            Littelfuse, Inc

Product Covered        Thyristor TO-92 Package EV series (Wire-Bonded)

Issue Date              April 14, 2012

It is hereby certified by Littelfuse, Inc., that there is neither RoHS (EU Directive 2011/65/EU)-restricted substance, nor such use, for materials to be used for unit parts, for packing/packaging materials, and for additives and the like in the manufacturing processes.

It is also certified by Littelfuse, Inc., that the products listed in this report do not contain Halogens and their compounds judged per widely accepted industrial guidelines.

In addition, it is hereby reported to you that the parts and sub-materials, the materials to be used for unit parts, the packing/packaging materials, and the additives and the like in the manufacturing processes, are all composed of the following components.

Issued by \_\_\_\_\_

< Koichiro Yoshimoto, Senior Product Engineer, Littelfuse, Inc.>

(1) Parts, sub-materials and unit parts

This document covers Thyristor TO-92 Package EV series, supplied by Littelfuse, Inc.  
Please see table 1 on page 2 for the list of products covered.

< Materials used >

Please see table 2 on page 3 and table 3 on page 4 of this document.

(2) The ICP data on all measurable substances

Please see annex 1 through 6 attached to this document.

Remarks :

**1. Pb (lead) contained in passivation glass on die bonding solder (item 3) and silicon wafer (item 6) to be categorized as exempt in RoHS Annex III 7(a) and 7(c)-I.**

**Please refer to Annex 7 of this report for the extract of the applicable exemptions of RoHS (EU Directive 2011/65/EU)**

**Table 1: Littelfuse Part Number covered by this report**

Standard (Catalog) Part Number		SPECIAL DEVICE P/N
L0103DE	MCR100-6	Any Special P/N which has base standard P/N listed in this table.
L0103ME	MCR100-8	
L0103NE	S402ES	
L0107DE	S4X8ES	S887S6X8ESRP
L0107ME	S4X8ES1	S890S4X8ES1
L1017NE	S4X8ES2	S891S6X8ES1
L0109DE	S602ES	
L0109ME	S6X8ES	
L0109NE	S6X8ES1	
LX803DE	S6X8ES2	
LX803ME	S8X8ES	
LX807DE	S8X8ES1	
LX807ME	S8X8ES2	
	Any Standard Part Number listed here may be followed by suffix for packing options, such as RP or AP.	

**Table 2: Homogeneous Material Used**

#	Description	Name of Material	Type	Analysis data
1	Lead finish	Hot solder dip	metal	annex 1.
2	Molding compound	Epoxy resin	plastic	annex 2.
3	Die bonding solder	Solder	metal	annex 3. Pb in this solder is exempted by RoHS Annex III 7(a). Please refer to Annex 7 for the RoHS exemption.
4	Die bonding wire	Gold	metal	annex 4
5	Lead frame	copper alloy	metal	annex 5.
6	Silicon wafer	silicon	metal	annex 6 Pb is from in passivation glass on wafer and is exempted by RoHS Annex III 7(c)-I. Please refer to Annex 7 for the RoHS exemption.
		aluminum	metal	
		glass	glass	

**Table 3: RoHS-regulated substance in raw materials**

Components	Analysis Result						
	Cd Cadmium	Cr Chromium	Hg Mercury	Pb Lead	PBB	PBDE	Total Halogens
<b>As Component Total</b> (Typical Values)	< 2ppm	< 2ppm	< 2ppm	<5 ppm* <sup>1</sup>	< 5 ppm	< 5 ppm	<100ppm
<b>Outside lead finish</b> (Hot-Tin dipping)  See Annex 1 for the detail.	< 2ppm	< 2ppm	< 2ppm	65ppm* <sup>2</sup>	< 5ppm	< 5ppm	---
<b>Epoxy Resin compound</b> (Mixture of resin, filler and fire retardant)  See Annex 2 for the detail.	< 0.5ppm	< 1ppm	< 2ppm	< 5ppm	< 5ppm	< 5ppm	126 ppm
<b>Die Bonding Solder</b>  See Annex 3 for the detail.	< 2ppm	< 2ppm	< 2ppm	88wt%* <sup>3</sup>	< 5ppm	< 5ppm	---
<b>Die-bonding Wire</b> (Au wire)  See Annex 4 for the detail.	< 0.5ppm	< 1ppm	< 2ppm	< 5ppm	< 5ppm	< 5ppm	---
<b>Lead frame</b> (Copper Alloy, KFC )  See Annex 5 for the detail.	< 2ppm	< 2ppm	< 2ppm	< 2ppm	---	---	---
<b>Silicon Die</b> (Silicon + Metal electrode + passivation glass)  See Annex 6 for the detail.	< 2ppm	< 2ppm	< 2ppm	2.3%* <sup>4</sup>	< 5ppm	< 5ppm	< 50ppm

\*1 Less than 5ppm Pb content overall, excluding Pb from passivation glass on the silicon die.

\*2 Pb (lead) contained in outside finish is not exempted from restriction by RoHS, but considered as process contamination. Littelfuse does not add Pb (lead) intentionally.

\*3 Pb (lead) contained in die-bonding solder is exempted from restriction by RoHS Annex III 7(a).

\*4 Pb (lead) contained in Silicon wafer is from passivation glass and is exempted from restriction by RoHS Annex III 7(c)-I.

Please refer to Annex 7 of this report for the applicable exemptions of RoHS (EU Directive EU Directive 2011/65/EU)



# Annex 1: Analysis Result of Outside Lead Finish Material (Page 3-4 of 5)



The result of this analysis is provided without any approval from Intertek. The results may vary from time to time.

Number: BK6H11070444

The result of this analysis is provided without any approval from Intertek. The results may vary from time to time.

### TEST REPORT

Test conducted :

# = According to IEC 62321, a positive result indicates the presence of Cr(VI) coating. It is the Cr(VI) concentration detected in the boiling-water-extraction solution and should not be interpreted as the Cr(VI) concentration in the coating layer of the sample.

Tester component: Metal part

(B) RoHS Requirement:

Restricted substances	Limits
Cadmium (Cd)	0.01% (100 mg/kg)
Lead (Pb)	0.1% (1000 mg/kg)
Mercury (Hg)	0.1% (1000 mg/kg)
Chromium VI (Cr <sup>VI</sup> )	0.1% (1000 mg/kg)
Polybrominated Diphenyl Ethers (PBDEs)	0.1% (1000 mg/kg)
Polybrominated Diphenyl Ether (PBDEs)	0.1% (1000 mg/kg)

The above limits were specified from 2012/06/EC and Amendment 2018/08/EC for homogeneous material.

(C) Test method:

Testing item	Testing method	Limit of Detection
Cadmium (Cd) Content	With reference to IEC 62321 Edition 1.0: 2008 Clause 9 - by acid digestion and determined by ICP-OES	2 mg/kg
Lead (Pb) Content	With reference to IEC 62321 Edition 1.0: 2008 Clause 9 - by acid digestion and determined by ICP-OES and ICP-AAS	2 mg/kg
Mercury (Hg) Content	With reference to IEC 62321 Edition 1.0: 2008 Clause 7 - by acid digestion and determined by ICP-OES	2 mg/kg
Chromium VI (Cr <sup>VI</sup> ) Content (for metal)	With reference to IEC 62321 Edition 1.0: 2008 Annex B - by spot test	Positive/ Negative (less than 0.1 mg/kg)
Chromium VI (Cr <sup>VI</sup> ) Content (for metal)	With reference to IEC 62321 Edition 1.0: 2008 Annex B - by boiling water extraction and determined by UV-VIS spectrophotometer	Negative (less than 0.02 mg/kg with 90% detection)
Polybrominated Diphenyl Ethers (PBDEs) & Polybrominated Diphenyl Ether (PBDEs)	With reference to IEC 62321 - Edition 1.0: 2008 Annex A - by solvent extraction and determined by GC/MS and further HPLC confirmation when necessary	0 mg/kg

Remark: Limit of detection = Detection limit of analyte in sample

**For the attention of KEC (Thailand) Co., Ltd.  
Product: Extrude bar SAC305, Tin Extrude bar  
Issue date 9-Nov-11**

Page 4 of 5

**Intertek Testing Services (Thailand) Limited**  
91, 3rd Floor, 3rd Floor, Chulalongkornrajavidyalaya Building, 10300 Bangkok  
Tel: (662) 939-8554, (662) 939-0961 Fax: (662) 939-0191  
E-mail Address: [thailand@intertek.com](mailto:thailand@intertek.com)

Reference is made to the (In-house) Certificate report number:

Number: BK6H11070444

### TEST REPORT

Test conducted :

(A) Test result summary:

Testing Item	Result
Cadmium (Cd) Content (mg/kg)	ND
Lead (Pb) Content (mg/kg)	95
Mercury (Hg) Content (mg/kg)	ND
Chromium VI (Cr <sup>VI</sup> ) Content (by spot test on metal)	Negative
Chromium VI (Cr <sup>VI</sup> ) Content (by boiling water extraction method) (mg/kg with 90% detection)	Negative (<0.02 mg/kg)
Polybrominated Diphenyl Ethers (PBDEs)	ND
Polybrominated Diphenyl Ether (PBDEs)	ND
Tetra-bromobisphenol A (TBBPA)	ND
Tetra-bromobisphenol A (TBBPA)	ND
Penta-bromobisphenol A (PBBs)	ND
Hexa-bromobisphenol A (HBBs)	ND
Hepta-bromobisphenol A (HBBs)	ND
Octa-bromobisphenol A (OBBs)	ND
Nona-bromobisphenol A (NBBs)	ND
Deca-bromobisphenol A (DBBs)	ND
Di-n-butyltin compound (DBTCL)	ND
Dibutyltin compound (DBTCL)	ND
Di-n-octyltin compound (DNOCLE)	ND
Dioctyltin compound (DNOCLE)	ND
Dibutyltin compound (DBTCL)	ND
Tetra-n-butyltin compound (TBBTCL)	ND
Hexa-n-butyltin compound (HBBTCL)	ND
Octa-n-butyltin compound (ONBBTCL)	ND
Deca-n-butyltin compound (DNBBTCL)	ND
Di-n-butyltin compound (DBTCL)	ND
Di-n-octyltin compound (DNOCLE)	ND
Dibutyltin compound (DBTCL)	ND
Di-n-octyltin compound (DNOCLE)	ND
Dioctyltin compound (DNOCLE)	ND
Dibutyltin compound (DBTCL)	ND
Di-n-octyltin compound (DNOCLE)	ND
Dioctyltin compound (DNOCLE)	ND
Dibutyltin compound (DBTCL)	ND
Di-n-octyltin compound (DNOCLE)	ND
Dioctyltin compound (DNOCLE)	ND
Dibutyltin compound (DBTCL)	ND
Di-n-octyltin compound (DNOCLE)	ND
Dioctyltin compound (DNOCLE)	ND

Name of operator: Kibnang T.  
mg/kg = Milligram per kilogram based on weight of sample  
mg/kg with 90% = Milligram per kilogram based on weight of sample with 90% detection

ND = Not Detected

Positive = A positive test result indicates the presence of Cr(VI) equal to or greater than three-fold of 1 mg/kg for spot test procedures or 0.02 mg/kg for boiling-water-extraction procedures with a sample surface area of 100 cm<sup>2</sup>. However, it shall not be interpreted as the Cr(VI) concentration in the coating layer of the sample and should not be used as a method detection limit for this qualitative test.

Negative = A negative test result indicates no above positive appearance has been found. When the spot test shows a negative result, the boiling-water-extraction procedure shall be used to verify the result. When the boiling-water-extraction procedure can't indicate the positive result, the result is negative.

Page 3 of 5

**Intertek Testing Services (Thailand) Limited**  
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Tel: (662) 939-8554, (662) 939-0961 Fax: (662) 939-0191  
E-mail Address: [thailand@intertek.com](mailto:thailand@intertek.com)

Reference is made to the (In-house) Certificate report number:

# Annex 1: Analysis Result of Outside Lead Finish Material (Page 5 of 5)

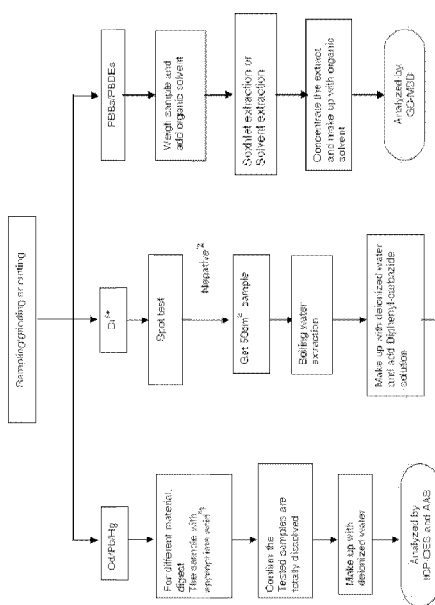


The report is for your reference only. It does not constitute a contract. The results do not constitute a warranty.

## TEST REPORT

Number: BKQH11070444

(1) Measurement Flowchart  
Test No. CUP2014/Chromium(VI)/Pb/Cd/As/Co/Br/S/Se  
Reference Standard : IEC 62321 Edition 1:02009



For the attention of **KEC (Thailand) Co., Ltd.**  
**Product: Extrude bar SAC302, Tin Extrude bar**  
**Issue date 9-Nov-11**

Remarks:  
\*1. List of appropriate Acid:  
Reagent: \_\_\_\_\_  
Reagent: \_\_\_\_\_  
Reagent: \_\_\_\_\_

\*2. If the result of Spot Test is positive, Chromium VI would be determined as detailed.  
Remarks: \_\_\_\_\_ E.N.D. \_\_\_\_\_ GC/MSD

## Annex 2: Analysis Result of Molding Compound (Page 1-4 of 7)



**Test Report No. F690101LF-CTSAYAA12-05501** Issued Date: 2012. 02. 16 Page 1 of 6

**To:** KCC CORPORATION(JEONJU PLANT#2)  
#648 Yongsamri  
Bongdong-eub  
Wanju-gun  
JEONBUK  
Korea

The following merchandise was submitted and identified by the client as:

**SGS File No.:** AYAA12-05501  
**Product Name:** KTMC-1050G+  
**Item No./Part No.:** N/A  
**Received Date:** 2012. 02. 09  
**Test Period:** 2012. 02. 10 to 2012. 02. 16  
**Test Results:** For further details, please refer to following page(s)  
**Test Performed:** SGS Korea tested the sample(s) selected by applicant with following results.

SGS Korea Co. Ltd.

*Jeff Jang*

Jeff Jang / Chemical Lab Mgr

Timothy Jeon  
Jinhee Kim  
Cindy Park  
Jerry Jung / Testing Person



**Test Report No. F690101LF-CTSAYAA12-05501** Issued Date: 2012. 02. 16 Page 2 of 6

**Sample No.:** AYAA12-05501.001  
**Sample Description:** KTMC-1050G+  
**Item No./Part No.:** N/A  
**Materials:** N/A

**Heavy Metals**

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	With reference to IEC 62321:2008, ICP	0.5	N.D.
Mercury (Hg)	mg/kg	With reference to IEC 62321:2008, ICP	2	N.D.
Lead (Pb)	mg/kg	With reference to IEC 62321:2008, ICP	5	N.D.
Hexavalent Chromium (Cr VI)	mg/kg	With reference to IEC 62321:2008, UV-VIS	1	N.D.
Antimony (Sb)	mg/kg	With reference to: EPA 8062(1996), US EPA 8210B(1996), ICP	10	N.D.

**Flame Retardants-PBBs/PBDEs**

Test Items	Unit	Test Method	MDL	Results
Monobromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Dibromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tribromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tetrabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Pentabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Hexabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Heptabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Octabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Nonabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Decabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Monobromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Dibromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tribromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Octabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Nonabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.

NOTE: (1) N.D. = Not detected (<MDL)  
(2) mg/kg = ppm  
(3) MDL = Method Detection Limit  
(4) \* = No regulation  
(5) \* = Boiling-water-extraction.  
Negative = Absence of CrVI coating  
Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

The information on this report is based on the test results of the sample submitted to SGS Korea Co., Ltd. for the purpose of the test. SGS Korea Co., Ltd. is not responsible for the accuracy of the information provided by the client. The information on this report is for the client's internal use only. It is not to be used for any other purpose. SGS Korea Co., Ltd. is a member of the SGS Group (Swiss General Inspection Services Group).  
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**Test Report No. F690101LF-CTSAYAA12-05501** Issued Date: 2012. 02. 16 Page 3 of 6

**Sample No.:** AYAA12-05501.001  
**Sample Description:** KTMC-1050G+  
**Item No./Part No.:** N/A  
**Materials:** N/A

**Flame Retardants-PBBs/PBDEs**

Test Items	Unit	Test Method	MDL	Results
Decabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.

**Halogen Contents**

Test Items	Unit	Test Method	MDL	Results
Bromine(Br)	mg/kg	BS EN 14582:2007, IC	30	N.D.
Chlorine(Cl)	mg/kg	BS EN 14582:2007, IC	30	126
Fluorine(F)	mg/kg	BS EN 14582:2007, IC	30	N.D.
Iodine(I)	mg/kg	BS EN 14582:2007, IC	50	N.D.

**Flame Retardants**

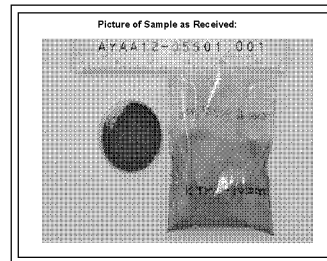
Test Items	Unit	Test Method	MDL	Results
Hexabromocyclododecane	mg/kg	USEPA 3540C, LC/MS	5	N.D.

NOTE: (1) N.D. = Not detected (<MDL)  
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(5) \* = Boiling-water-extraction.  
Negative = Absence of CrVI coating  
Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

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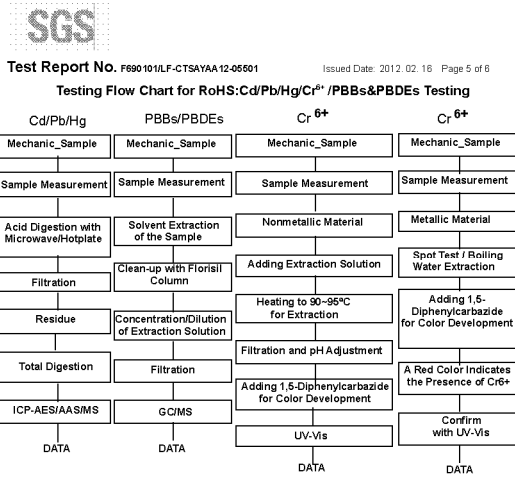
**Test Report No. F690101LF-CTSAYAA12-05501** Issued Date: 2012. 02. 16 Page 4 of 6



NOTE: (1) N.D. = Not detected (<MDL)  
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Negative = Absence of CrVI coating  
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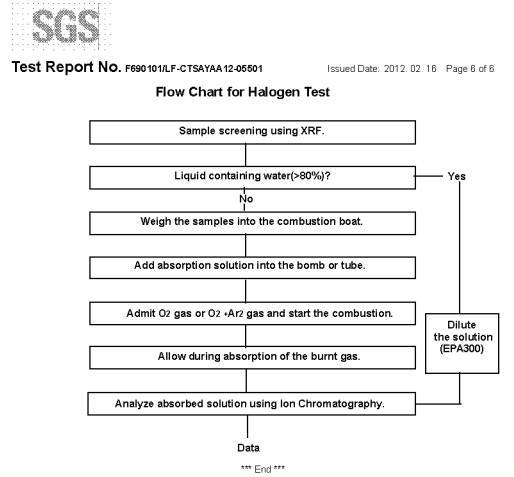
## Annex 2: Analysis Result of Molding Compound (Page 5-6 of 6)



NOTE: (1) N.D. = Not detected (=MDL)  
 (2) mg/kg = ppm  
 (3) MDL = Method Detection Limit  
 (4) \* = No regulation  
 (5) \* = Boiling-water-extraction.  
 Negative = Absence of CrVI coating  
 Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

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NOTE: (1) N.D. = Not detected (=MDL)  
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 (4) \* = No regulation  
 (5) \* = Boiling-water-extraction.  
 Negative = Absence of CrVI coating  
 Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

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# Annex 3: Analysis Result of Die-Bonding Solder (Page 1-4 of 6)



**Test Report** No. 10247220(2) Date: 20-Sep-11 Page 1 of 6

Heraeus Materials Singapore Pte Ltd  
No. 2 Corporation Road, #06-15/16/17 Corporation Place, Singapore 618434

The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : PbSn10Ag2 Solder Wire

Sample Receiving Date : 13-Sep-11  
Testing Period : 13-Sep-11 to 20-Sep-11

Test Requested : In accordance with the RoHS Directive 2002/95/EC, and its amendment directives.

Test Result(s) : Please refer to next page(s).


Conclusion : Based on the performed tests on submitted sample(s), the results **comply** with the RoHS Directive 2002/95/EC and its subsequent amendments.

Signed for and on behalf of  
SGS Testing & Control Services Singapore Pte Ltd

T.C. Tham  
Laboratory Manager

Test Location: 25 Aier Road, Crescent #07-07, Singapore 139944  
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**Test Report** No. 10247220(2) Date: 20-Sep-11 Page 2 of 6


**Test Results:**

Sample Description : PbSn10Ag2 Solder Wire

Test Item(s):	Unit	Method	Results	MDL	RoHS Limit
Cadmium (Cd)	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by ICP/AES	n.d.	2	100
Lead (Pb)	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by ICP/AES	855189.5	2	1000
Mercury (Hg)	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by ICP/AES	n.d.	2	1000
Hexavalent Chromium (Cr(VI)) (By spot test / boiling water extraction)	---	With reference to IEC62321, Ed1:2008 and performed by Spot test / boiling water extraction method. (See Note 5)	Negative	0.02 mg/kg with 50 cm <sup>2</sup> surface area	#
<b>Sum of PBBs</b>	mg/kg		n.d.	5	1000
Monobromobiphenyl	mg/kg		n.d.	5	-
Dibromobiphenyl	mg/kg		n.d.	5	-
Tribromobiphenyl	mg/kg		n.d.	5	-
Tetrabromobiphenyl	mg/kg		n.d.	5	-
Pentabromobiphenyl	mg/kg		n.d.	5	-
Hexabromobiphenyl	mg/kg		n.d.	5	-
Heptabromobiphenyl	mg/kg		n.d.	5	-
Octabromobiphenyl	mg/kg		n.d.	5	-
Nonabromobiphenyl	mg/kg		n.d.	5	-
Decabromobiphenyl	mg/kg		n.d.	5	-
<b>Sum of PBDEs</b>	mg/kg		n.d.	5	1000
Monobromodiphenyl ether	mg/kg	With reference to IEC62321, Ed1:2008. Analysis was performed by GC/MS	n.d.	5	-
Dibromodiphenyl ether	mg/kg		n.d.	5	-
Tribromodiphenyl ether	mg/kg		n.d.	5	-
Tetrabromodiphenyl ether	mg/kg		n.d.	5	-
Pentabromodiphenyl ether	mg/kg		n.d.	5	-
Hexabromodiphenyl ether	mg/kg		n.d.	5	-
Heptabromodiphenyl ether	mg/kg		n.d.	5	-
Octabromodiphenyl ether	mg/kg		n.d.	5	-
Nonabromodiphenyl ether	mg/kg		n.d.	5	-
Decabromodiphenyl ether ##	mg/kg		n.d.	5	-

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**Test Report** No. 10247220(2) Date: 20-Sep-11 Page 3 of 6

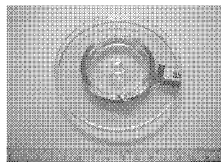
Note:

- (1) mg/kg = ppm; 0.1wt% = 1000ppm
- (2) n.d. = Not Detected
- (3) MDL = Method Detection Limit
- (4) ## = The exemption of DecaBDE in polymeric application according 2006/7/17/EC was covered by the European Court of Justice by its decision of 01/04/2008. Subsequently DecaBDE will be included in the sum of PBDE after 01/07/2008.
- (5) "-" = Not regulated
- (6) "\*" = No used (Qualitative Test)
- (7) "+" = Exceeds limit
- (8) # = Positive means the presence of Cr(VI) on the tested areas.  
Negative means the absence of Cr(VI) on the tested areas.
- (9) Spot-test:  
Positive = Presence of Cr(VI) coating / surface layer  
Negative = Absence of Cr(VI) coating / surface layer  
The tested sample should be further verified by boiling-water-extraction method if the spot test result cannot be confirmed.
- (10) Boiling-water extraction:  
Negative = Absence of Cr(VI) coating / surface layer  
Positive = Presence of Cr(VI) coating / surface layer  
The detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

\*Exemption: The received sample is exempted under directive 2002/95/EC Annex Article 7: lead in high melting temperature solder type solders. (i.e. tin-lead solder alloys containing more than 95% of lead).  
Lab Analysis(s): Jay Jay and Eileen  
Remarks: Sample received was totally dissolved by preconditioning method.


**Sample photo:**  
Sample Description : PbSn10Ag2 Solder Wire

SGS authenticates the photos on original report only



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**Test Report** No. 10247220(2) Date: 20-Sep-11 Page 4 of 6

**Process Flow of IEC62321 (Pb, Cd, Hg & Cr(VI))**

```

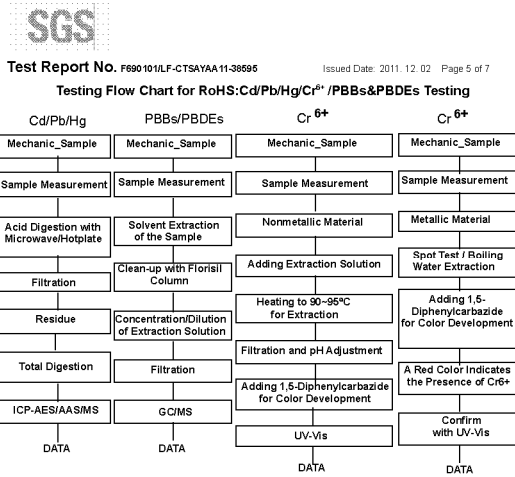
    graph TD
      A[Cutting / Preparation] --> B[Sample Measurement]
      B --> C[Pb, Cd]
      B --> D[Hg]
      B --> E[Cr(VI)]
      C --> F[Acid digestion by suitable amount of sample in nitric acid]
      D --> G[Microwave digestion with HNO3/HCl/HF]
      E --> H[Add appropriate amount of digestion reagent]
      F --> I[Filtration]
      G --> I
      H --> J[Heat to appropriate temperature to extract]
      I --> K[Solution]
      J --> K
      J --> L[Cool, filter, digestate through filter]
      K --> M[ICP-AES]
      L --> N[Dilute with 20% HCl to dissolve]
      L --> O[Add diphenyl-carbazide for color development]
      N --> P[Measure the absorbance at 540 nm by UV-VIS]
      O --> P
  
```

Remarks: Sample received was totally dissolved by preconditioning method. (Cr(VI) method excluded)

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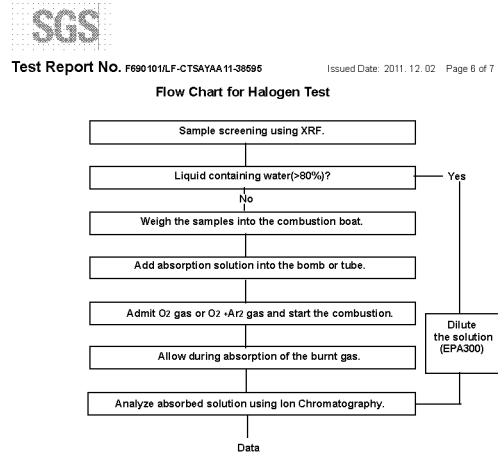
# Annex 3: Analysis Result of Die-Bonding Solder (Page 5-7 of 7)



The samples were dissolved totally by pre-conditioning method according to above flow chart for Cd,Pb,Hg  
Section Chief : Gilsae Yi

NOTE: (1) N.D. = Not detected (<MDL)  
(2) mg/kg = ppm  
(3) MDL = Method Detection Limit  
(4) - = No regulation  
(5) \*\* = Qualitative analysis (No Unit)  
(6) \* = Boiling-water-extraction  
Negative = Absence of CrVI coating  
Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

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NOTE: (1) N.D. = Not detected (<MDL)  
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# Annex 4: Analysis Result of Die-bonding Wire (Page 1-4 of 7)



**Test Report No. F690101LF-CTSAYAA11-38595** Issued Date: 2011. 12. 02 Page 1 of 7

**To:** HESUNG METAL CO., LTD.  
#693-1  
Gojan-dong  
Namdong-gu  
Incheon  
Korea

The following merchandise was submitted and identified by the client as:

**SGS File No.:** AYAA11-38595  
**Product Name:** Gold Bonding Wire(4N)  
**Item No./Part No.:** Gold Bonding Wire(4N)  
**Received Date:** 2011. 11. 29  
**Test Period:** 2011. 11. 30 to 2011. 12. 02  
**Test Results:** For further details, please refer to following page(s)  
**Test Perform ed:** SGS Korea tested the sample(s) selected by applicant with following results.

SGS Korea Co. Ltd.



Jeff Jang / Chemical Lab Mgr

Timothy Jeon  
Jinhee Kim  
Cindy Park  
Jerry Jung / Testing Person

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F052 View 04d



**Test Report No. F690101LF-CTSAYAA11-38595** Issued Date: 2011. 12. 02 Page 2 of 7

**Sample No.:** AYAA11-38595.001  
**Sample Description:** Gold Bonding Wire(4N)  
**Item No./Part No.:** Gold Bonding Wire(4N)  
**Materials:** Au

**Heavy Metals**

Test Items	Unit	Test Method	MDL	Results
Cadmium (Cd)	mg/kg	With reference to IEC 62321:2008, ICP	0.5	N.D.
Lead (Pb)	mg/kg	With reference to IEC 62321:2008, ICP	5	N.D.
Mercury (Hg)	mg/kg	With reference to IEC 62321:2008, ICP	2	N.D.
Hexavalent Chromium (Cr VI) By boiling water extraction*	**	With reference to IEC 62321:2008	-	Negative
Antimony (Sb)	mg/kg	With reference to EPA 9051(1995), US EPA 6010D(1990), ICP	10	N.D.

**Flame Retardants/PBBs/PBDEs**

Test Items	Unit	Test Method	MDL	Results
Monobromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Di-bromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tribromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tetrabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Pentabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Hexabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Heptabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Octabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Nonabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Decabromobiphenyl	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Monobromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Di-bromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tribromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Tetrabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Pentabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Hexabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Heptabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Octabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.

NOTE: (1) N.D. = Not detected (<MDL)  
(2) mg/kg = ppm  
(3) MDL = Method Detection Limit  
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(5) \*\* = Qualitative analysis (No Unit)  
(6) \* = Boiling-water-extraction  
Negative = Absence of CrVI coating  
Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area

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**Test Report No. F690101LF-CTSAYAA11-38595** Issued Date: 2011. 12. 02 Page 3 of 7

**Sample No.:** AYAA11-38595.001  
**Sample Description:** Gold Bonding Wire(4N)  
**Item No./Part No.:** Gold Bonding Wire(4N)  
**Materials:** Au

**Flame Retardants/PBBs/PBDEs**

Test Items	Unit	Test Method	MDL	Results
Nonabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.
Decabromodiphenyl ether	mg/kg	With reference to IEC 62321:2008, GC-MS	5	N.D.

**Halogen Contents**

Test Items	Unit	Test Method	MDL	Results
Bromine(Br)	mg/kg	With reference to ASTM D 7369-08 IC	30	N.D.
Chlorine(Cl)	mg/kg	With reference to ASTM D 7369-08 IC	30	N.D.
Fluorine(F)	mg/kg	With reference to ASTM D 7369-08 IC	30	N.D.
Iodine(I)	mg/kg	With reference to ASTM D 7369-08 IC	50	N.D.

**Flame Retardants**

Test Items	Unit	Test Method	MDL	Results
TetrabromobisphenolA	mg/kg	US EPA 3540C, GC/MS	10	N.D.

**Others(s)**

Test Items	Unit	Test Method	MDL	Results
PFDA(Perfluorooctanoic acid)	mg/kg	US EPA 3540C/3550C, LC/MS	1	N.D.
PFOS(Perfluorooctane Sulfonates, Acid/Meis/Salt/Amide)	mg/kg	US EPA 3540C/3550C, LC/MS	1	N.D.

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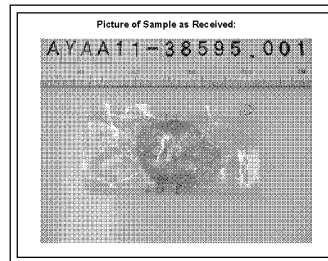
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**Test Report No. F690101LF-CTSAYAA11-38595** Issued Date: 2011. 12. 02 Page 4 of 7



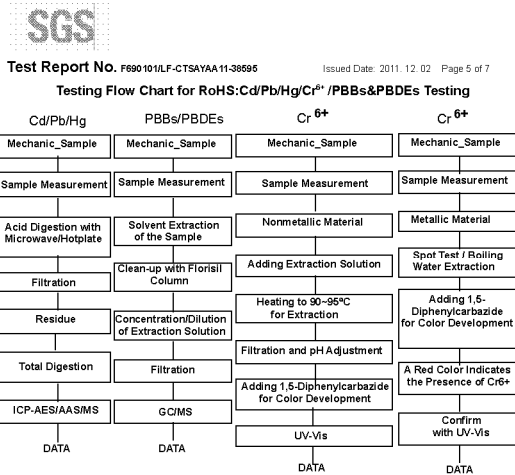
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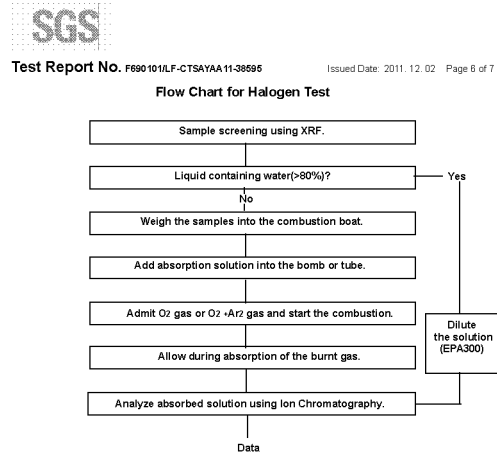
## Annex 4: Analysis Result of Die-bonding Wire (Page 5-7 of 7)



The samples were dissolved totally by pre-conditioning method according to above flow chart for Cd,Pb,Hg.  
Section Chief : Gilsae Yi

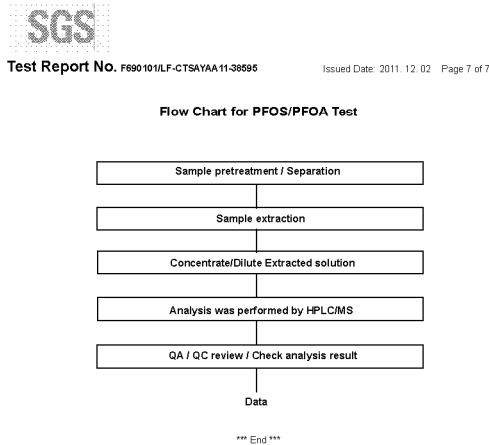
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(6) \* = Boiling-water-extraction  
Negative = Absence of CrVI coating  
Positive = Presence of CrVI coating, the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample surface area.

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# Annex 5: Analysis Result of Lead Frame (page 1-4 of 4)



**Test Report No.** 2177136 **Date :** 23-Feb-2012 **Page 1 of 4**

**Client :** TSP - T Co.,Ltd.,  
Northern Region Industrial Estate 123 Moo 4,  
T.Banklang, A. Muang, Lamphun 51000 Thailand

The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : Lead Frame  
Sample No. : 2239919  
Sample Condition : Sample is contained in plastic bag.  
Quantity Submitted : 48.15 g.  
Part No. : TC-92 Ag 0-4077 PMC  
Lot No. : TS 1206-0729-101  
Manufacturer : Poongsan  
Country of Origin : Korea  
Country of Destination : Thailand  
Buyer's Name : IEC T.


Sample Receiving Date : 20-Feb-2012  
Testing Period : 20-Feb-2012 to 23-Feb-2012

Test Requested : In accordance with the RoHS Directive 2011/65/EU Annex II : recasting 2002/95/EC

Test Method : (1) With reference to IEC 62321:2006 for Lead content, Analysis was performed by ICP-OES.  
(2) With reference to IEC 62321:2006 for Cadmium content, Analysis was performed by ICP-OES.  
(3) With reference to IEC 62321:2006 for Mercury content, Analysis was performed by ICP-OES.  
(4) With reference to IEC 62321:2006 for Hexavalent Chromium by Colorless and Colored Chromate Coating on Metals/ Colorimetric Method, Analysis was performed by UV-Vis spectrometry.

Test Results : Please refer to next page.

Signed for and on behalf of  
SGS (Thailand) Limited

  
Pornpana Lirathpong  
Hardlines Testing Manager

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**TEST RESULTS**

Test results by chemical method (Unit: mg/kg)

Test Item (s):	Method (Refer to)	Result (1)	MDL	RoHS Limit
Lead (Pb)	(1)	n.d.	2	1000
Cadmium (Cd)	(2)	n.d.	2	100
Mercury (Hg)	(3)	n.d.	2	1000
Hexavalent Chromium (CrVI) by Spot-test / boiling water extraction (optional)	(4)	Negative	-	#

Test Part Description  
Result (1) metal

Note :  
(a) mg/kg = ppm ; 0.1wt% = 1000 ppm  
(b) n.d. = Not Detected  
(c) MDL = Method Detection Limit  
(d) Spot-test:  
Negative = Absence of CrVI coating. Positive = Presence of CrVI coating.  
[The tested sample should be further verified by boiling-water-extraction method if the spot test result cannot be confirmed.]  
Boiling-water-extraction:  
Negative = Absence of CrVI coating  
Positive = Presence of CrVI coating; the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm<sup>2</sup> sample area.  
(e) # = Positive indicates the presence of Hexavalent Chromium on the areas and result be regarded as conflict with RoHS requirement.  
Negative indicates the absence of CrVI on the tested areas and result be regarded as no conflict with RoHS requirement.  
(f) "-" = Not regulated.  
(g) For corrosion protection coatings on metals; information on storage conditions and production date of the tested sample is unavailable and thus results of Cr(VI) represent status of the sample at the time of testing represent status of the sample at the time of testing.

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RoHS Check List (RoHS) (Cr(VI) ODF) (Pb-Free) (Pb-Free) Testing

- RoHS Check List (RoHS)
- RoHS Check List (Cr(VI) ODF)
- The sample was checked totally by pre-determined method approved by before RoHS/REACH (Cr(VI) and Pb-Free) test method with self!

```

graph TD
    A[RoHS Check List (RoHS) (Cr(VI) ODF) (Pb-Free) (Pb-Free) Testing] --> B[Material Sample Preparation]
    B --> C[Sample Measurement]
    C --> D[Pb-Cd-Hg]
    C --> E[Pb-Free]
    C --> F[Cr(VI)]
    D --> D1[ICP-OES]
    D1 --> D2[DATA]
    E --> E1[Colorimetric]
    E1 --> E2[DATA]
    F --> F1[Spot-test]
    F1 --> F2[Negative]
    F2 --> F3[Boiling water extraction]
    F3 --> F4[ICP-OES]
    F4 --> F5[DATA]
  
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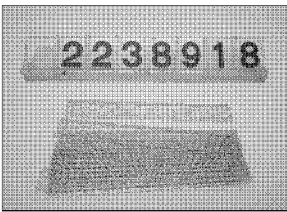
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**Test Report No.** 2177136 **Date :** 23-Feb-2012 **Page 4 of 4**

**SAMPLE/ATTACHMENT PICTURE**



\*\*\*\*\* End of Report \*\*\*\*\*

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# Annex 6: Analysis Result of Silicon Wafer (Page 1-4 of 7)



Validity unknown  
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**Test Report** No.: CE/2011/E0307 Date: 2011/11/21 Page: 1 of 7  
LITE-ON SEMICONDUCTOR CORP.  
28-1, WU-SHIN ST., TA WU LUNG, KEELUNG, TAIWAN, R. O. C.

The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description : WAFER  
System No : THYRISTOR  
Sample Receiving Date : 2011/11/16  
Testing Period : 2011/11/16 TO 2011/11/21

Test Result(s) : Please refer to next page(s)



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**Test Report** No.: CE/2011/E0307 Date: 2011/11/21 Page: 2 of 7  
LITE-ON SEMICONDUCTOR CORP.  
28-1, WU-SHIN ST., TA WU LUNG, KEELUNG, TAIWAN, R. O. C.

**Test Results**

PART NAME No.1 : WAFER

Test Item(s)	Unit	Method	MDL	Result No.1
Cadmium (Cd)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES	2	n.d.
Lead (Pb)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES	2	23100
Mercury (Hg)	mg/kg	With reference to IEC 62321: 2008 and performed by ICP-AES	2	n.d.
Hexavalent Chromium Cr(VI)	mg/kg	With reference to IEC 62321: 2008 and performed by UV-VIS	2	n.d.
<b>Sum of PBBs</b>				
Monobromodiphenyl ether				5 n.d.
Dibromodiphenyl ether				5 n.d.
Tribromodiphenyl ether				5 n.d.
Tetrabromodiphenyl ether				5 n.d.
Pentabromodiphenyl ether				5 n.d.
Hexabromodiphenyl ether				5 n.d.
Heptabromodiphenyl ether				5 n.d.
Octabromodiphenyl ether				5 n.d.
Nonabromodiphenyl ether				5 n.d.
Decabromodiphenyl ether				5 n.d.
<b>Sum of PBDEs</b>				
Monobromodiphenyl ether				5 n.d.
Dibromodiphenyl ether				5 n.d.
Tribromodiphenyl ether				5 n.d.
Tetrabromodiphenyl ether				5 n.d.
Pentabromodiphenyl ether				5 n.d.
Hexabromodiphenyl ether				5 n.d.
Heptabromodiphenyl ether				5 n.d.
Octabromodiphenyl ether				5 n.d.
Nonabromodiphenyl ether				5 n.d.
Decabromodiphenyl ether				5 n.d.

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LITE-ON SEMICONDUCTOR CORP.  
28-1, WU-SHIN ST., TA WU LUNG, KEELUNG, TAIWAN, R. O. C.

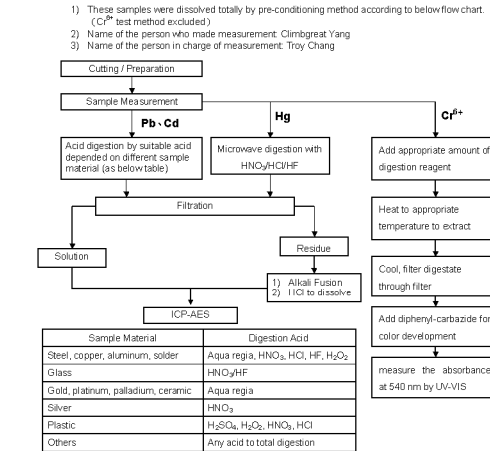
Test Item(s)	Unit	Method	MDL	Result
<b>Halogen</b>				
Halogen-Fluorine (F) (CAS No.: 14782-94-8)			50	n.d.
Halogen-Chlorine (Cl) (CAS No.: 22837-15-1)	mg/kg	With reference to BS EN 14582:2007. Analysis was performed by IC.	50	n.d.
Halogen-Bromine (Br) (CAS No.: 10897-32-2)			50	n.d.
Halogen-Iodine (I) (CAS No.: 14382-44-8)			50	n.d.

Note:  
1. mg/kg = ppm ; 0.1wt% = 1000ppm  
2. n.d. = Not Detected  
3. MDL = Method Detection Limit  
4. \* = Not Regulated

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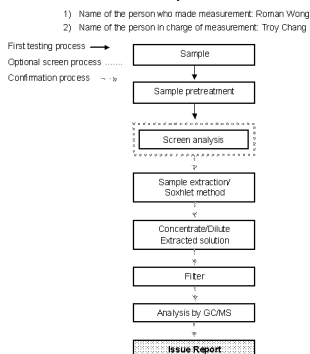
# Annex 6: Analysis Result of Silicon Wafer (Page 5-7 of 7)


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 LITE-ON SEMI CONDUCTOR CORP.  
 28-1, WU-SHIN ST., TA WU LUNG, KEELUNG, TAIWAN, R. O. C.

**PBB/PBDE analytical FLOWCHART**


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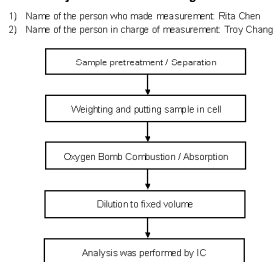
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 中華民國 100 年 11 月 21 日

**Test Report**

No.: CE/2011/B3037 Date: 2011/11/21

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 LITE-ON SEMI CONDUCTOR CORP.  
 28-1, WU-SHIN ST., TA WU LUNG, KEELUNG, TAIWAN, R. O. C.

**Analytical flow chart of halogen content**


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 中華民國 100 年 11 月 21 日

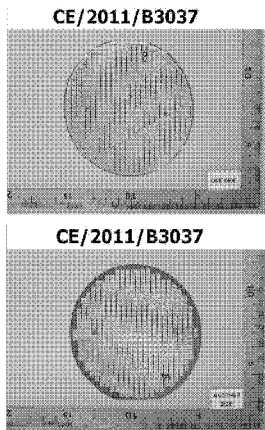

**Test Report**

No.: CE/2011/B3037 Date: 2011/11/21

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 LITE-ON SEMI CONDUCTOR CORP.  
 28-1, WU-SHIN ST., TA WU LUNG, KEELUNG, TAIWAN, R. O. C.

\* The tested sample / part is marked by an arrow if it's shown on the photo. \*



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 中華民國 100 年 11 月 21 日

## Annex 7: Applicable RoHS exemptions (2011/65/EU Annex III)

1.7.2011

EN

Official Journal of the European Union

L 174/103

Exemption		Scope and dates of applicability
6(a)	Lead as an alloying element in steel for machining purposes and in galvanised steel containing up to 0,35 % lead by weight	
6(b)	Lead as an alloying element in aluminium containing up to 0,4 % lead by weight	
6(c)	Copper alloy containing up to 4 % lead by weight	
7(a)	Lead in high melting temperature type solders (i.e. lead-based alloys containing 85 % by weight or more lead)	
7(b)	Lead in solders for servers, storage and storage array systems, network infrastructure equipment for switching, signalling, transmission, and network management for telecommunications	
7(c)-I	Electrical and electronic components containing lead in a glass or ceramic other than dielectric ceramic in capacitors, e.g. piezoelectronic devices, or in a glass or ceramic matrix compound	
7(c)-II	Lead in dielectric ceramic in capacitors for a rated voltage of 125 V AC or 250 V DC or higher	
7(c)-III	Lead in dielectric ceramic in capacitors for a rated voltage of less than 125 V AC or 250 V DC	Expires on 1 January 2013 and after that date may be used in spare parts for EEE placed on the market before 1 January 2013
8(a)	Cadmium and its compounds in one shot pellet type thermal cut-offs	Expires on 1 January 2012 and after that date may be used in spare parts for EEE placed on the market before 1 January 2012
8(b)	Cadmium and its compounds in electrical contacts	
9	Hexavalent chromium as an anticorrosion agent of the carbon steel cooling system in absorption refrigerators up to 0,75 % by weight in the cooling solution	
9(b)	Lead in bearing shells and bushes for refrigerant-containing compressors for heating, ventilation, air conditioning and refrigeration (HVACR) applications	
11(a)	Lead used in C-press compliant pin connector systems	May be used in spare parts for EEE placed on the market before 24 September 2010
11(b)	Lead used in other than C-press compliant pin connector systems	Expires on 1 January 2013 and after that date may be used in spare parts for EEE placed on the market before 1 January 2013
12	Lead as a coating material for the thermal conduction module C-ring	May be used in spare parts for EEE placed on the market before 24 September 2010
13(a)	Lead in white glasses used for optical applications	
13(b)	Cadmium and lead in filter glasses and glasses used for reflectance standards	
14	Lead in solders consisting of more than two elements for the connection between the pins and the package of microprocessors with a lead content of more than 80 % and less than 85 % by weight	Expired on 1 January 2011 and after that date may be used in spare parts for EEE placed on the market before 1 January 2011